

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes
For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory IECQ Certificate No.: IECQ-L ULTW 08.0001

CB Certificate No.: TW-HSPM-ITL-1003

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Appendix-1 List of approved testing scope

Product/	Standard/Testing	Ranges	Remarks
Product category	method		
Metals and alloy type material	IEC62321	Pb: (2 to 10000) mg/kg Cd: (2 to 1000) mg/kg Hg: (2 to 1000) mg/kg	
Polymer and composite material	IEC62321	Pb: (2 to 10000) mg/kg Cd: (2 to 1000) mg/kg Hg: (2 to 1000) mg/kg	
	IEC62321	Cr (VI): (2 to 1000) mg/kg	
	IEC62321	PBBs: (10 to 20000) mg/kg PBDEs: (10 to 20000) mg/kg	
	EN 14582	F/Cl/Br/I/other anion: (25 to 1000)	
Electronic and electrical (e.g. electronic components / materials and raw materials)	IEC62321	Pb: (2 to 10000) mg/kg Cd: (2 to 1000) mg/kg Hg: (2 to 1000) mg/kg	
	IEC62321	Cr (VI): (2 to 1000) mg/kg	
	IEC62321	PBBs: (10 to 20000) mg/kg PBDEs: (10 to 20000) mg/kg	
	EN 14582	F/Cl/Br/I/other anion: (25 to 1000)	
Others	IEC62321	Pb: (2 to 10000) mg/kg Cd: (2 to 1000) mg/kg Hg: (2 to 1000) mg/kg	
	IEC62321	Cr (VI): (2 to 1000) mg/kg	
	IEC62321	PBBs: (10 to 20000) mg/kg PBDEs: (10 to 20000) mg/kg	
	EN 14582	F/Cl/Br/I/other anion: (25 to 1000)	

US-NAI, ECCC T.R.C.C. sign: Date: Aug. 9, 2017

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